

Search Notes

Application/Control No.

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Examiner

Thuy V. Tran

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
*	updated search	7/24/2005	T.T.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR